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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,247,110	09-1993	Bank, Howard M.	556/415
*	B	US-5,567,596	10-1996	Diamond et al.	435/13
*	C	US-5,576,216	11-1996	Patchornik, Avraham	436/86
*	D	US-6,063,633	05-2000	Willson, III, Richard C.	436/37
*	E	US-6,312,896	11-2001	Heroux et al.	435/6
*	F	US-6,316,616	11-2001	Jacobsen et al.	540/484
*	G	US-2002/0045190	04-2002	Wilson et al.	435/7.1
*	H	US-2002/0141900	10-2002	Guan et al.	422/68.1
*	I	US-2002/0182735	12-2002	Kibby et al.	436/37
*	J	US-2003/0143648	07-2003	Cravatt et al.	435/7.23
*	K	US-6,602,714	08-2003	Tagge et al.	506/37
*	L	US-6,627,445	09-2003	Akporiaye et al.	436/37
*	M	US-2003/0211536	11-2003	Geysen, H. Mario	435/7.1

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	2327754	02-1999	GB	Murrer	
	O	01/00869	01-2001	WO	Nathan	
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	Burtie, J. G. et al, Analytical Chemistry 1955, 27, 1215-1217.			
	V	Ekstrom, A. et al, Journal of Physical Chemistry, 1989, 93, 5230-5237.			
	W	Quirke, J. M. E. et al, Analytical Chemistry 1994, 66, 1302-1315.			
	X	Cavanaugh, M. D. et al, Organometallics 1996, 15, 2764-2769.			

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0077096	04-2004	Nayar et al.	436/057
*	B	US-2005/0106655	05-2005	Savage et al.	435/023
*	C	US-2007/0161039	07-2007	Wagner et al.	435/007.1
*	D	US-2007/0243556	10-2007	Wachs, Israel E.	435/007.1
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	Lesley, G. et al, Organometallics 1996, 15, 5137-5154.			
	V	Cao, P. et al, Journal of Chromatography A 1997, 759, 111-117.			
	W	Chen, Y.-X. (E.) et al, Journal of the American Chemical Society 1998, 120, 6287-6305.			
	X	McGuinness, D. S. et al, Journal of Organometallic Chemistry 1998, 565, 165-178.			

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Stevenson, D. E. et al, Enzyme and Microbial Technology 1999, 25, 357-363.
	V	Lin, S. et al, Macromolecules 1999, 32, 8283-8290.
	W	Jia, C. et al, Journal of the American Chemical Society 2000, 122, 7252-7263.
	X	Novak, T. J. et al, Journal of Pharmaceutical and Biomedical Analysis 2000, 23, 705-713.

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited

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*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A US-			
	B US-			
	C US-			
	D US-			
	E US-			
	F US-			
	G US-			
	H US-			
	I US-			
	J US-			
	K US-			
	L US-			
	M US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N				
	O				
	P				
	Q				
	R				
	S				
	T				

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	Mikkelsen, O. et al, Microporous and Mesoporous Materials 2000, 40, 95-113.
V	Torisawa, Y. et al, Organic Process Research & Development 2001, 5, 84-88.
W	Voskoboynikov, A. Z. et al, Organometallics 2001, 20, 2794-2801.
X	Choo, H. et al, Journal of Physical Chemistry B 001, 105, 7730-7738.

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/587,177		Applicant(s)/Patent Under Reexamination WAGNER ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	Miller, K. J. et al, Organometallics 2001, 20, 4403-4412.			
	V	Higashi, T. et al, Journal of Chromatography B 2002, 772, 229-238.			
	W	Roy, A. K. et al, Journal of the American Chemical Society 2002, 124, 9510-9524.			
	X	Britovsek, G. J. P. et al, Inorganica Chimica Acta 2003, 345, 279-291.			

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Ma, S., Accounts of Chemical Research 2003, 36, 701-712.
	V	Na, Y, et al, Journal of the American Chemical Society 2004, 126, 250-258.
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.